

High-reliability discrete products and engineering services since 1977

MAC229(A) SERIES

SILICON BIDIRECTIONAL THYRISTORS

FEATURES

- Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.
- Available as non-RoHS (Sn/Pb plating), standard, and as RoHS by adding "-PBF" suffix.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Peak repetitive off-state voltage ⁽¹⁾			
(T _J = -40 to +110°C, ½ sine wave, 50 to 60Hz, gate open)			
MAC229-4, MAC229A-4	V_{DRM}	200	Volts
MAC229-6, MAC229A-6	V DRM	400	VOILS
MAC229-8, MAC229A-8		600	
MAC229-10, MAC229A-10		800	
RMS on-state current (Full cycle sine wave, 50 to 60Hz, T _C = 80°C)	I _{T(RMS)}	8	Amps
Peak non-repetitive surge current			A
(1 cycle, 60Hz, T _J = 110°C)	I _{TSM}	80	Amps
Circuit fusing considerations (t = 8.3ms)	I ² t	26	A ² s
Peak gate current ($t \le 2\mu s$)	I _{GM}	±2	Amps
Peak gate voltage $(t \le 2\mu s)$	V_{GM}	±10	Volts
Peak gate power ($t \le 2\mu s$)	P_{GM}	20	Watts
Average gate power ($T_C = 80^{\circ}C$, $t \le 8.3$ ms)	P _{G(AV)}	0.5	Watts
Operating junction temperature range	T _J	-40 to +110	°C
Storage temperature range	T _{stg}	-40 to +150	°C
Mounting torque		8	In. lb.

Note 1: VDEM for all types can be applied on a continuous basis. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

THERMAL CHARACTERISTICS

THE MANUAL CONTROL CON					
Characteristic	Symbol	Maximum	Unit		
Thermal resistance, junction to case	R _{eJC}	2.2	°C/W		
Thermal resistance, junction to ambient	$R_{\Theta JA}$	60	°C/W		

ELECTRICAL CHARACTERISTICS (T_C = 25°C and either polarity of MT2 to MT1 voltage unless otherwise noted)

Characteristic	Symbol	Min	Тур.	Max	Unit
Peak blocking current (2)					
$(V_D = Rated V_{DRM}, gate open, T_J = 25^{\circ}C)$	I _{DRM}	-	-	10	μΑ
$(V_D = Rated V_{DRM}, gate open, T_J = 110^{\circ}C)$		-	-	2	mA
Peak on-state voltage	.,				\
($I_{TM} = 11A$ peak, pulse width ≤ 2 ms, duty cycle ≤ 2 %.)	V _{TM}	-	-	1.8	Volts
Gate trigger current (continuous dc)					
$(V_D = 12V, R_L = 100\Omega)$					A
MT2(+),G(+); MT2(+),G(-); MT2(-),G(-)	I _{GT}	-	-	10	mA
MT2(-),G(+) "A" suffix only		-	-	15	



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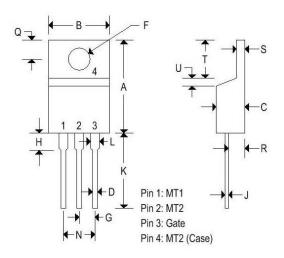
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Gate trigger voltage (continuous dc)					
$(V_D = 12V, R_L = 100\Omega)$					
MT2(+),G(+); MT2(+),G(-); MT2(-),G(-)		-	-	2.0	
MT2(-),G(+) "A" suffix only	V_{GT}	-	-	2.5	Volts
$(V_D = Rated V_{DRM}, R_L = 10k\Omega, T_C = 110^{\circ}C)$					
MT2(+),G(+); MT2(+),G(-); MT2(-),G(-), all types		0.2	-	-	
MT2(-),G(+) "A" suffix only		0.2	-	-	
Holding current					
(V _D = 12V, I _{TM} = 200mA, gate open)	I _H	-	-	15	mA
Gate controlled turn-on time					
$(V_D = Rated V_{DRM}, I_{TM} = 16A, I_G = 30mA)$	t _{gt}	-	1.5	-	μs
Critical rate of rise of off-state voltage	dv/dt				V/µs
$(V_D = Rated V_{DRM}, exponential waveform, T_C = 110°C)$		-	25	-	
Critical rate of rise of commutation voltage	dv/dt(c)				V/µs
$(V_D = Rated V_{DRM}, I_{TM} = 11.3A peak, commutating di/dt = 4.1A/ms, gate unenergized,$		-	5	-	
$T_C = 80$ °C)					

MECHANICAL CHARACTERISTICS

Case TO-220AB				
Marking	Alpha-numeric			
Pin out	See below			



	TO-220AB			
	Inches		Millim	eters
	Min	Max	Min	Max
Α	0.575	0.620	14.600	15.750
В	0.380	0.405	9.650	10.290
C	0.160	0.190	4.060	4.820
D	0.025	0.035	0.640	0.890
F	0.142	0.147	3.610	3.730
G	0.095	0.105	2.410	2.670
Н	0.110	0.155	2.790	3.930
J	0.014	0.022	0.360	0.560
K	0.500	0.562	12.700	14.270
L	0.045	0.055	1.140	1.390
N	0.190	0.210	4.830	5.330
Q	0.100	0.120	2.540	3.040
R	0.080	0.110	2.040	2.790
S	0.045	0.055	1.140	1.390
T	0.235	0.255	5.970	6.480
U	14	0.050	197	1.270
٧	0.045		1.140	
Z	2	0.080	-	2.030



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